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Applications of "[Embedded - Microcontrollers](#)"

Details

Product Status	Active
Core Processor	ARM® Cortex®-M4
Core Size	32-Bit Single-Core
Speed	100MHz
Connectivity	CANbus, I ² C, IrDA, LINbus, MMC/SD, QSPI, SAI, SPI, UART/USART, USB OTG
Peripherals	Brown-out Detect/Reset, DMA, I ² S, LCD, POR, PWM, WDT
Number of I/O	60
Program Memory Size	1.5MB (1.5M x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	320K x 8
Voltage - Supply (Vcc/Vdd)	1.7V ~ 3.6V
Data Converters	A/D 16x12b; D/A 2x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	81-UFBGA, WLCSP
Supplier Device Package	81-WLCSP (4.04x3.95)
Purchase URL	https://www.e-xfl.com/product-detail/stmicroelectronics/stm32f423mhy6tr

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1 Introduction

This datasheet provides the description of the STM32F423xH microcontrollers.

For information on the Cortex[®]-M4 core, please refer to the Cortex[®]-M4 programming manual (PM0214) available from www.st.com.



3.16 Power supply schemes

- $V_{DD} = 1.7$ to 3.6 V: external power supply for I/Os with the internal supervisor (POR/PDR) disabled, provided externally through V_{DD} pins. Requires the use of an external power supply supervisor connected to the V_{DD} and NRST pins.
- V_{SSA} , $V_{DDA} = 1.7$ to 3.6 V: external analog power supplies for ADC, Reset blocks, RCs and PLL. V_{DDA} and V_{SSA} must be connected to V_{DD} and V_{SS} , respectively, with decoupling technique.

Note: The V_{DD}/V_{DDA} minimum value of 1.7 V is obtained with the use of an external power supply supervisor (refer to [Section 3.17.2: Internal reset OFF](#)). Refer to [Table 4: Regulator ON/OFF and internal power supply supervisor availability](#) to identify the packages supporting this option.

- $V_{BAT} = 1.65$ to 3.6 V: power supply for RTC, external clock 32 kHz oscillator and backup registers (through power switch) when V_{DD} is not present.
- V_{DDUSB} can be connected either to V_{DD} or an external independent power supply (3.0 to 3.6 V) for USB transceivers.

For example, when device is powered at 1.8 V, an independent power supply 3.3 V can be connected to V_{DDUSB} . When the V_{DDUSB} is connected to a separated power supply, it is independent from V_{DD} or V_{DDA} but it must be the last supply to be provided and the first to disappear.

The following conditions V_{DDUSB} must be respected:

- During power-on phase ($V_{DD} < V_{DD_MIN}$), V_{DDUSB} should be always lower than V_{DD}
- During power-down phase ($V_{DD} < V_{DD_MIN}$), V_{DDUSB} should be always lower than V_{DD}
- V_{DDUSB} rising and falling time rate specifications must be respected.
- In operating mode phase, V_{DDUSB} could be lower or higher than V_{DD} :
 - If USB is used, the associated GPIOs powered by V_{DDUSB} are operating between V_{DDUSB_MIN} and V_{DDUSB_MAX} .
 - If USB is not used, the associated GPIOs powered by V_{DDUSB} are operating between V_{DD_MIN} and V_{DD_MAX} .

3.18.1 Regulator ON

On packages embedding the BYPASS_REG pin, the regulator is enabled by holding BYPASS_REG low. On all other packages, the regulator is always enabled.

There are three power modes configured by software when the regulator is ON:

- MR is used in the nominal regulation mode (With different voltage scaling in Run mode)
In Main regulator mode (MR mode), different voltage scaling are provided to reach the best compromise between maximum frequency and dynamic power consumption.
- LPR is used in the Stop mode
The LP regulator mode is configured by software when entering Stop mode.
- Power-down is used in Standby mode.
The Power-down mode is activated only when entering in Standby mode. The regulator output is in high impedance and the kernel circuitry is powered down, inducing zero consumption. The contents of the registers and SRAM are lost.

Depending on the package, one or two external ceramic capacitors should be connected on the VCAP_1 and VCAP_2 pins. The VCAP_2 pin is only available on 100- and 144-pin packages.

All packages have the regulator ON feature.

3.18.2 Regulator OFF

This feature is available only on UFBGA100 and UFBGA144 packages, which feature the BYPASS_REG pin. The regulator is disabled by holding BYPASS_REG high. The regulator OFF mode allows to supply externally a V_{12} voltage source through VCAP_1 and VCAP_2 pins.

Since the internal voltage scaling is not managed internally, the external voltage value must be aligned with the targeted maximum frequency.

The two 2.2 μ F ceramic capacitors should be replaced by two 100 nF decoupling capacitors.

When the regulator is OFF, there is no more internal monitoring on V_{12} . An external power supply supervisor should be used to monitor the V_{12} of the logic power domain. PA0 pin should be used for this purpose, and act as power-on reset on V_{12} power domain.

In regulator OFF mode, the following features are no more supported:

- PA0 cannot be used as a GPIO pin since it allows to reset a part of the V_{12} logic power domain which is not reset by the NRST pin.
- As long as PA0 is kept low, the debug mode cannot be used under power-on reset. As a consequence, PA0 and NRST pins must be managed separately if the debug connection under reset or pre-reset is required.

3.18.3 Regulator ON/OFF and internal reset ON/OFF availability

Table 4. Regulator ON/OFF and internal power supply supervisor availability

Package	Regulator ON	Regulator OFF	Power supply supervisor ON	Power supply supervisor OFF
UFQFPN48	Yes	No	Yes	No
LQFP64	Yes	No	Yes	No
WLCSP81	Yes BYPASS_REG set to V_{SS}	Yes BYPASS_REG set to V_{DD}	Yes PDR_ON set to V_{DD}	Yes PDR_ON set to V_{SS}
LQFP100	Yes	No	Yes	No
LQFP144	Yes	No	Yes PDR_ON set to V_{DD}	Yes PDR_ON set to V_{SS}
UFBGA100	Yes BYPASS_REG set to V_{SS}	Yes BYPASS_REG set to V_{DD}		
UFBGA144	Yes BYPASS_REG set to V_{SS}	Yes BYPASS_REG set to V_{DD}		

3.19 Real-time clock (RTC) and backup registers

The backup domain includes:

- The real-time clock (RTC)
- 20 backup registers

The real-time clock (RTC) is an independent BCD timer/counter. Dedicated registers contain the second, minute, hour (in 12/24 hour), week day, date, month, year, in BCD (binary-coded decimal) format. Correction for 28, 29 (leap year), 30, and 31 day of the month are performed automatically. The RTC features a reference clock detection, a more precise second source clock (50 or 60 Hz) can be used to enhance the calendar precision. The RTC provides a programmable alarm and programmable periodic interrupts with wakeup from Stop and Standby modes. The sub-seconds value is also available in binary format.

It is clocked by a 32.768 kHz external crystal, resonator or oscillator, the internal low-power RC oscillator or the high-speed external clock divided by 128. The internal low-speed RC has a typical frequency of 32 kHz. The RTC can be calibrated using an external 512 Hz output to compensate for any natural quartz deviation.

Two alarm registers are used to generate an alarm at a specific time and calendar fields can be independently masked for alarm comparison. To generate a periodic interrupt, a 16-bit programmable binary auto-reload downcounter with programmable resolution is available and allows automatic wakeup and periodic alarms from every 120 μ s to every 36 hours.

A 20-bit prescaler is used for the time base clock. It is by default configured to generate a time base of 1 second from a clock at 32.768 kHz.

The backup registers are 32-bit registers used to store 80 byte of user application data when V_{DD} power is not present. Backup registers are not reset by a system, a power reset, or when the device wakes up from the Standby mode (see [Section 3.20: Low-power modes](#)).

The main USB OTG FS features are:

- Combined Rx and Tx FIFO size of 320 × 35 bits with dynamic FIFO sizing
- Support of session request protocol (SRP) and host negotiation protocol (HNP)
- 6 bidirectional endpoints
- 12 host channels with periodic OUT support
- HNP/SNP/IP inside (no need for any external resistor)
- For OTG/Host modes, a power switch is needed when bus-powered devices are connected
- Link Power Management (LPM)
- Battery Charging Detection (BCD) supporting DCP, CDP and SDP

3.34 Random number generator (RNG)

All devices embed an RNG that delivers 32-bit random numbers generated by an integrated analog circuit.

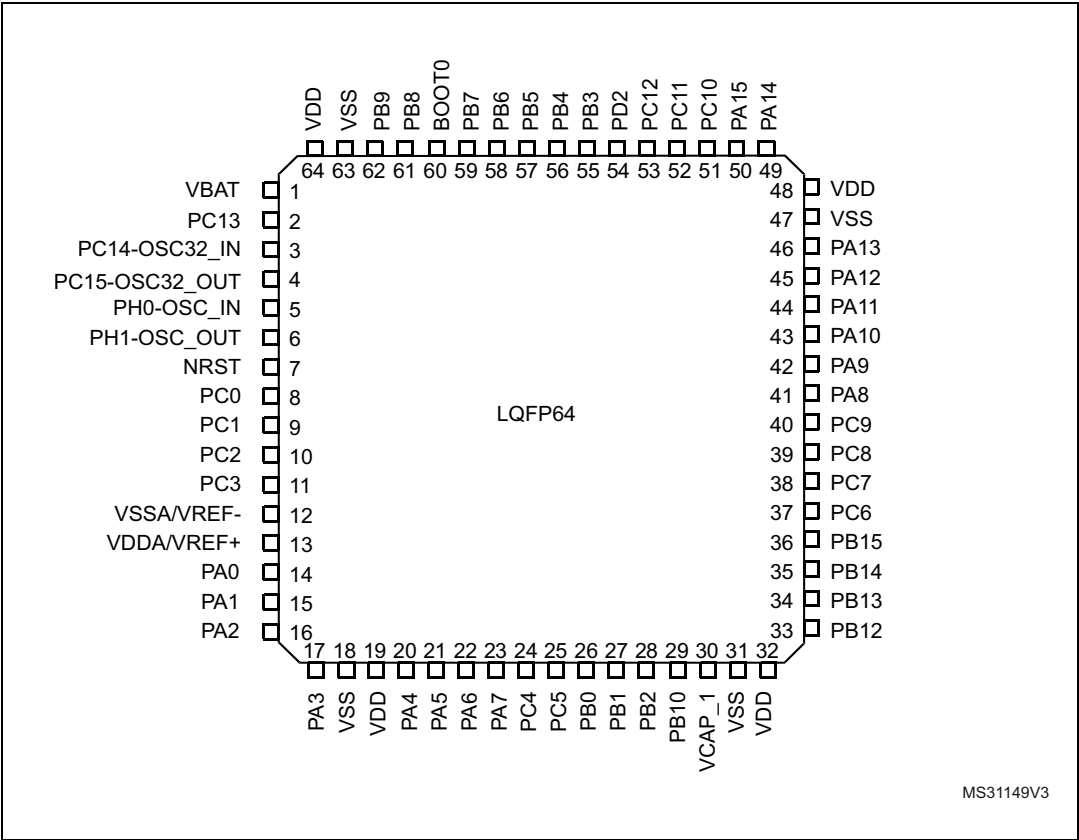
3.35 Advanced encryption standard hardware accelerator (AES)

The devices embed an AES hardware accelerator can be used to both encipher and decipher data using AES algorithm.

The AES peripheral supports:

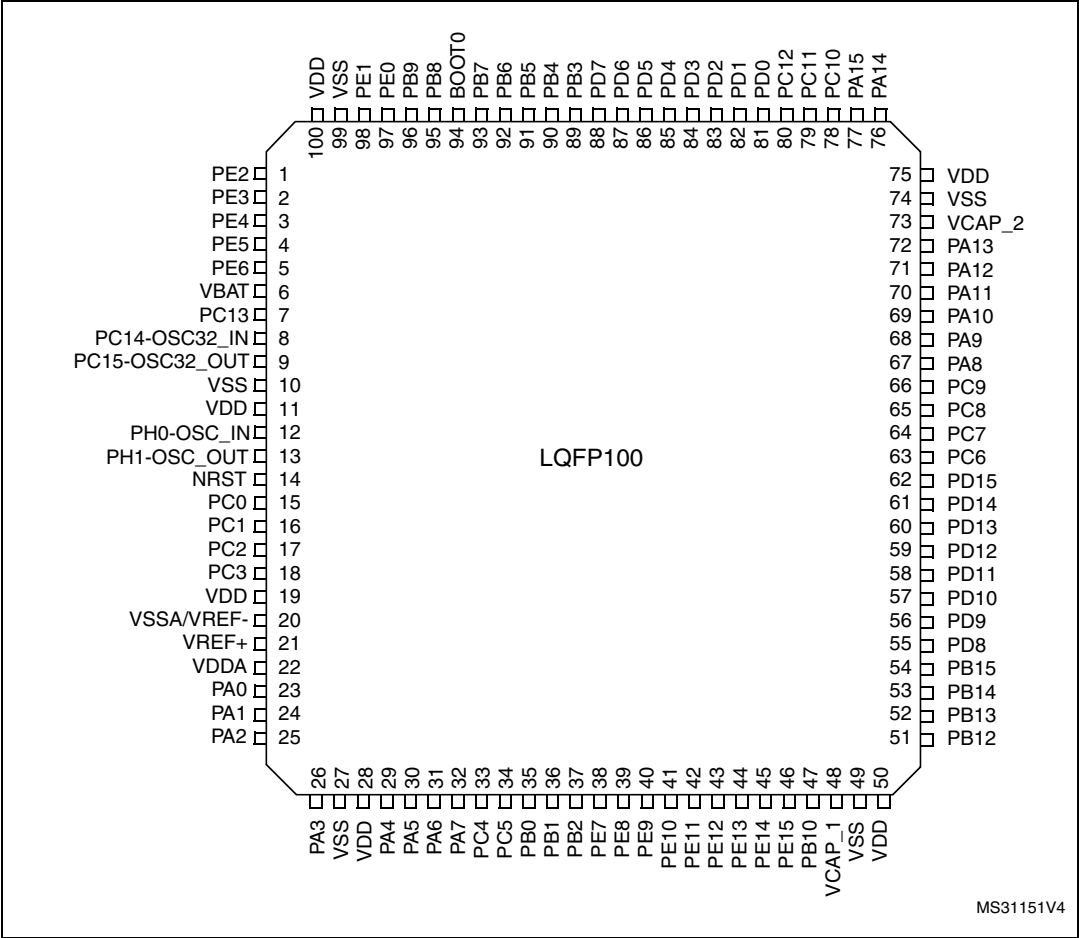
- Encryption/Decryption using AES Rijndael Block Cipher algorithm
- NIST FIPS 197 compliant implementation of AES encryption/decryption algorithm
- 128-bit and 256-bit register for storing the encryption, decryption or derivation key (4x 32-bit registers)
- Electronic codebook (ECB), Cipher block chaining (CBC), Counter mode (CTR), Galois Counter Mode (GCM), Galois Message Authentication Code mode (GMAC) and Cipher Message Authentication Code mode (CMAC) supported.
- Key scheduler
- Key derivation for decryption
- 128-bit data block processing
- 128-bit, 256-bit key length
- 1x32-bit INPUT buffer and 1x32-bit OUTPUT buffer.
- Register access supporting 32-bit data width only.
- One 128-bit Register for the initialization vector when AES is configured in CBC mode or for the 32-bit counter initialization when CTR mode is selected, GCM mode or CMAC mode.
- Automatic data flow control with support of direct memory access (DMA) using 2 channels, one for incoming data, and one for outgoing data.
- Suspend a message if another message with a higher priority needs to be processed.

Figure 13. STM32F423xH LQFP64 pinout



1. The above figure shows the package top view.

Figure 14. STM32F423xH LQFP100 pinout



1. The above figure shows the package top view.

Table 10. STM32F423xH pin definition (continued)

Pin Number							Pin name (function after reset) ⁽¹⁾	Pin type	I/O structure	Notes	Alternate functions	Additional functions
UFQFPN48	LQFP64	WLCSP81	LQFP100	UFBGA100	UFBGA144	LQFP144						
-	9	C7	16	J2	H2	27	PC1	I/O	FT	-	LPTIM1_OUT, DFSDM2_DATIN4, SAI1_SD_B, EVENTOUT	ADC1_IN11, WKUP3
-	10	D7	17	J3	H3	28	PC2	I/O	FT	-	LPTIM1_IN2, DFSDM2_DATIN7, SPI2_MISO, I2S2ext_SD, SAI1_SCK_B, DFSDM1_CKOUT, FSMC_NWE, EVENTOUT	ADC1_IN12
-	11	E7	18	K2	H4	29	PC3	I/O	FT	-	LPTIM1_ETR, DFSDM2_CKIN7, SPI2_MOSI/I2S2_SD, SAI1_FS_B, FSMC_A0, EVENTOUT	ADC1_IN13
-	-	-	19	-	-	30	VDD	S	-	-	-	-
8	12	H9	20	J1	J1	31	VSSA	S	-	-	-	-
-	-	-	-	K1	K1	-	VREF-	S	-	-	-	-
-	-	G8	21	L1	L1	32	VREF+	S	-	-	-	-
9	13	F7	22	M1	M1	33	VDDA	S	-	-	-	-
10	14	G7	23	L2	J2	34	PA0	I/O	FT	-	TIM2_CH1/TIM2_ETR, TIM5_CH1, TIM8_ETR, USART2_CTS, UART4_TX, EVENTOUT	ADC1_IN0, WKUP1
11	15	H8	24	M2	K2	35	PA1	I/O	FT	-	TIM2_CH2, TIM5_CH2, SPI4_MOSI/I2S4_SD, USART2_RTS, UART4_RX, QUADSPI_BK1_IO3, EVENTOUT	ADC1_IN1
12	16	J9	25	K3	L2	36	PA2	I/O	FT	-	TIM2_CH3, TIM5_CH3, TIM9_CH1, I2S2_CKIN, USART2_TX, FSMC_D4/FSMC_DA4, EVENTOUT	ADC1_IN2
13	17	E6	26	L3	M2	37	PA3	I/O	FT	-	TIM2_CH4, TIM5_CH4, TIM9_CH2, I2S2_MCK, USART2_RX, SAI1_SD_B, FSMC_D5/FSMC_DA5, EVENTOUT	ADC1_IN3

Table 11. FSMC pin definition (continued)

Pins	FSMC		64 pins	81 pins	100 pins	144 pins
	LCD/NOR/ PSRAM/SRAM	NOR/PSRAM Mux				
PA3	D5	DA5	Yes	Yes	Yes	Yes
PA4	D6	DA6	Yes	Yes	Yes	Yes
PA5	D7	DA7	Yes	Yes	Yes	Yes
PC4	NE4	NE4	Yes	Yes	Yes	Yes
PC5	NOE	NOE	Yes	Yes	Yes	Yes
PF12	A6	-	-	-	-	Yes
PF13	A7	-	-	-	-	Yes
PF14	A8	-	-	-	-	Yes
PF15	A9	-	-	-	-	Yes
PG0	A10	-	-	-	-	Yes
PG1	A11	-	-	-	-	Yes
PE7	D4	DA4	-	-	Yes	Yes
PE8	D5	DA5	-	-	Yes	Yes
PE9	D6	DA6	-	Yes	Yes	Yes
PE10	D7	DA7	-	Yes	Yes	Yes
PE11	D8	DA8	-	Yes	Yes	Yes
PE12	D9	DA9	-	Yes	Yes	Yes
PE13	D10	DA10	-	Yes	Yes	Yes
PE14	D11	DA11	-	Yes	Yes	Yes
PE15	D12	DA12	-	Yes	Yes	Yes
PB12	D13	DA13	Yes	Yes	Yes	Yes
PB14	D0	DA0	Yes	Yes	Yes	Yes
PD8	D13	DA13	-	-	-	Yes
PD9	D14	DA14	-	Yes	Yes	Yes
PD10	D15	DA15	-	Yes	Yes	Yes
PD11	A16	A16	-	-	Yes	Yes
PD12	A17	A17	-	-	Yes	Yes
PD13	A18	A18	-	-	Yes	Yes
PD14	D0	DA0	-	-	Yes	Yes
PD15	D1	DA1	-	-	Yes	Yes
PG2	A12	-	-	-	-	Yes
PG3	A13	-	-	-	-	Yes
PG4	A14	-	-	-	-	Yes

Table 11. FSMC pin definition (continued)

Pins	FSMC		64 pins	81 pins	100 pins	144 pins
	LCD/NOR/ PSRAM/SRAM	NOR/PSRAM Mux				
PG5	A15	-	-	-	-	Yes
PC6	D1	DA1	Yes	Yes	Yes	Yes
PC11	D2	DA2	Yes	Yes	Yes	Yes
PC12	D3	DA3	Yes	Yes	Yes	Yes
PD0	D2	DA2	-	Yes	Yes	Yes
PD1	D3	DA3	-	-	Yes	Yes
PD2	NWE	NWE	Yes	Yes	Yes	Yes
PD3	CLK	CLK	-	-	Yes	Yes
PD4	NOE	NOE	-	-	Yes	Yes
PD5	NWE	NWE	-	-	Yes	Yes
PD6	NWAIT	NWAIT	-	-	Yes	Yes
PD7	NE1	NE1	-	-	Yes	Yes
PG9	NE2	NE2	-	-	-	Yes
PG10	NE3	NE3	-	-	-	Yes
PG12	NE4	NE4	-	-	-	Yes
PG13	A24	A24	-	-	-	Yes
PG14	A25	A25	-	-	-	Yes
PB7	NL	NL	Yes	Yes	Yes	Yes
PE0	NBL0	NBL0	-	-	Yes	Yes
PE1	NBL1	NBL1	-	-	Yes	Yes

Table 38. Switching output I/O current consumption

Symbol	Parameter	Conditions ⁽¹⁾	I/O toggling frequency (f _{sw})	Typ	Unit
IDDIO	I/O switching current	$V_{DD} = 3.3\text{ V}$ $C = C_{INT}$	2 MHz	0.05	mA
			8 MHz	0.15	
			25 MHz	0.45	
			50 MHz	0.85	
			60 MHz	1.00	
			84 MHz	1.40	
			90 MHz	1.67	
		$V_{DD} = 3.3\text{ V}$ $C_{EXT} = 0\text{ pF}$ $C = C_{INT} + C_{EXT} + C_S$	2 MHz	0.10	
			8 MHz	0.35	
			25 MHz	1.05	
			50 MHz	2.20	
			60 MHz	2.40	
			84 MHz	3.55	
			90 MHz	4.23	
		$V_{DD} = 3.3\text{ V}$ $C_{EXT} = 10\text{ pF}$ $C = C_{INT} + C_{EXT} + C_S$	2 MHz	0.20	
			8 MHz	0.65	
			25 MHz	1.85	
			50 MHz	2.45	
			60 MHz	4.70	
			84 MHz	8.80	
			90 MHz	10.47	
		$V_{DD} = 3.3\text{ V}$ $C_{EXT} = 22\text{ pF}$ $C = C_{INT} + C_{EXT} + C_S$	2 MHz	0.25	
			8 MHz	1.00	
			25 MHz	3.45	
			50 MHz	7.15	
			60 MHz	11.55	
		$V_{DD} = 3.3\text{ V}$ $C_{EXT} = 33\text{ pF}$ $C = C_{INT} + C_{EXT} + C_S$	2 MHz	0.32	
			8 MHz	1.27	
			25 MHz	3.88	
			50 MHz	12.34	

1. CS is the PCB board capacitance including the pad pin. CS = 7 pF (estimated value).

On-chip peripheral current consumption

The MCU is placed under the following conditions:

- At startup, all I/O pins are in analog input configuration.
- All peripherals are disabled unless otherwise mentioned.
- The ART accelerator is ON.
- Voltage Scale 2 mode selected, internal digital voltage V12 = 1.26 V.
- HCLK is the system clock at 100 MHz. $f_{PCLK1} = f_{HCLK}/2$, and $f_{PCLK2} = f_{HCLK}$.
The given value is calculated by measuring the difference of current consumption
 - with all peripherals clocked off,
 - with only one peripheral clocked on,
 - scale 1 with $f_{HCLK} = 100$ MHz,
 - scale 2 with $f_{HCLK} = 84$ MHz,
 - scale 3 with $f_{HCLK} = 64$ MHz.
- Ambient operating temperature is 25 °C and $V_{DD}=3.3$ V.

Table 39. Peripheral current consumption

Peripheral		I _{DD} (Typ)			Unit
		Scale 1	Scale 2	Scale 3	
AHB1	GPIOA	1.89	1.82	1.64	μA/MHz
	GPIOB	1.75	1.68	1.52	
	GPIOC	1.70	1.64	1.48	
	GPIOD	1.72	1.65	1.48	
	GPIOE	1.78	1.71	1.55	
	GPIOF	1.68	1.62	1.45	
	GPIOG	1.66	1.61	1.44	
	GPIOH	0.72	0.69	0.63	
	CRC	0.30	0.30	0.28	
	DMA1 ⁽¹⁾	1.75N + 3.14	1.66N + 3.00	1.49N + 2.70	
	DMA2 ⁽¹⁾	1.79N + 3.29	1.71N + 3.14	1.53N + 2.82	
AHB2	RNG	0.72	0.70	0.63	μA/MHz
	USB_OTG_FS	19.26	18.37	16.47	
	AES	2.75	2.63	2.36	
AHB3	FSMC	5.42	5.18	4.64	μA/MHz
	QSPI	10.33	9.86	8.84	

Table 71. QSPI dynamic characteristics in DDR mode⁽¹⁾ (continued)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$t_{w(CKH)}$	QSPI clock high and low time	-	$t_{(CK)} / 2 - 1$	-	$t_{(CK)} / 2$	ns
$t_{w(CKL)}$			$t_{(CK)} / 2$	-	$t_{(CK)} / 2 + 1$	
$t_{sr(IN)}$, $t_{sf(IN)}$	Data input setup time	$2.7\text{ V} < V_{DD} < 3.6\text{ V}$	0.5	-	-	
		$1.71\text{ V} < V_{DD} < 3.6\text{ V}$	0.5	-	-	
$t_{hr(IN)}$, $t_{hf(IN)}$	Data input hold time	$2.7\text{ V} < V_{DD} < 3.6\text{ V}$	2	-	-	
		$1.71\text{ V} < V_{DD} < 3.6\text{ V}$	2	-	-	
$t_{vr(OUT)}$, $t_{vf(OUT)}$	Data output valid time	$2.7\text{ V} < V_{DD} < 3.6\text{ V}$	-	8.5	9	
		$1.71\text{ V} < V_{DD} < 3.6\text{ V}$	-	8.5	11.5	
$t_{hr(OUT)}$, $t_{hf(OUT)}$	Data output hold time	-	7.5	-	-	

1. Guaranteed by characterization results.

USB OTG full speed (FS) characteristics

This interface is present in USB OTG FS controller.

Table 72. USB OTG FS startup time

Symbol	Parameter	Max	Unit
$t_{STARTUP}^{(1)}$	USB OTG FS transceiver startup time	1	μs

1. Guaranteed by design.

Table 73. USB OTG FS DC electrical characteristics

Symbol	Parameter	Conditions	Min. ⁽¹⁾	Typ.	Max. ⁽¹⁾	Unit
Input levels	V_{DD}	USB OTG FS operating voltage	3.0 ⁽²⁾	-	3.6	V
	$V_{DI}^{(3)}$	Differential input sensitivity	I(USB_FS_DP/DM)	0.2	-	V
	$V_{CM}^{(3)}$	Differential common mode range	Includes V_{DI} range	0.8	-	
	$V_{SE}^{(3)}$	Single ended receiver threshold		1.3	-	
Output levels	V_{OL}	Static output level low	R_L of 1.5 k Ω to 3.6 V ⁽⁴⁾	-	-	V
	V_{OH}	Static output level high	R_L of 15 k Ω to V_{SS} ⁽⁴⁾	2.8	-	
R_{PD}	PA11, PA12 (USB_FS_DM/DP)	$V_{IN} = V_{DD}$	17	21	24	k Ω
	PA9 (OTG_FS_VBUS)		0.65	1.1	2.0	
R_{PU}	PA11, PA12 (USB_FS_DM/DP)	$V_{IN} = V_{SS}$	1.5	1.8	2.1	
	PA9 (OTG_FS_VBUS)	$V_{IN} = V_{SS}$	0.25	0.37	0.55	

1. All the voltages are measured from the local ground potential.

6.3.20 12-bit ADC characteristics

Unless otherwise specified, the parameters given in [Table 75](#) are derived from tests performed under the ambient temperature, f_{PCLK2} frequency and V_{DDA} supply voltage conditions summarized in [Table 17](#).

Table 75. ADC characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{DDA}	Power supply	$V_{DDA} - V_{REF+} < 1.2\text{ V}$	1.7 ⁽¹⁾	-	3.6	V
V_{REF+}	Positive reference voltage		1.7 ⁽¹⁾	-	V_{DDA}	
V_{REF-}	Negative reference voltage	-	-	0	-	
f_{ADC}	ADC clock frequency	$V_{DDA} = 1.7^{(1)}\text{ to }2.4\text{ V}$	0.6	15	18	MHz
		$V_{DDA} = 2.4\text{ to }3.6\text{ V}$	0.6	30	36	MHz
$f_{TRIG}^{(2)}$	External trigger frequency	$f_{ADC} = 30\text{ MHz}$, 12-bit resolution	-	-	1764	kHz
		-	-	-	17	$1/f_{ADC}$
V_{AIN}	Conversion voltage range ⁽³⁾	-	0 (V_{SSA} or V_{REF-} tied to ground)	-	V_{REF+}	V
$R_{AIN}^{(2)}$	External input impedance	See Equation 1 for details	-	-	50	k Ω
$R_{ADC}^{(2)(4)}$	Sampling switch resistance	-	-	-	6	k Ω
$C_{ADC}^{(2)}$	Internal sample and hold capacitor	-	-	4	7	pF
$t_{lat}^{(2)}$	Injection trigger conversion latency	$f_{ADC} = 30\text{ MHz}$	-	-	0.100	μs
		-	-	-	3 ⁽⁵⁾	$1/f_{ADC}$
$t_{latr}^{(2)}$	Regular trigger conversion latency	$f_{ADC} = 30\text{ MHz}$	-	-	0.067	μs
		-	-	-	2 ⁽⁵⁾	$1/f_{ADC}$
$t_S^{(2)}$	Sampling time	$f_{ADC} = 30\text{ MHz}$	0.100	-	16	μs
		-	3	-	480	$1/f_{ADC}$
$t_{STAB}^{(2)}$	Power-up time	-	-	2	3	μs
$t_{CONV}^{(2)}$	Total conversion time (including sampling time)	$f_{ADC} = 30\text{ MHz}$ 12-bit resolution	0.50	-	16.40	μs
		$f_{ADC} = 30\text{ MHz}$ 10-bit resolution	0.43	-	16.34	μs
		$f_{ADC} = 30\text{ MHz}$ 8-bit resolution	0.37	-	16.27	μs
		$f_{ADC} = 30\text{ MHz}$ 6-bit resolution	0.30	-	16.20	μs
		9 to 492 (t_S for sampling + n-bit resolution for successive approximation)				$1/f_{ADC}$

6.3.22 V_{BAT} monitoring characteristics

Table 83. V_{BAT} monitoring characteristics

Symbol	Parameter	Min	Typ	Max	Unit
R	Resistor bridge for V_{BAT}	-	50	-	K Ω
Q	Ratio on V_{BAT} measurement	-	4	-	
$E_r^{(1)}$	Error on Q	-1	-	+1	%
$T_{S_vbat}^{(2)(2)}$	ADC sampling time when reading the V_{BAT} 1 mV accuracy	5	-	-	μ s

1. Guaranteed by design.
2. Shortest sampling time can be determined in the application by multiple iterations.

6.3.23 Embedded reference voltage

The parameters given in [Table 84](#) are derived from tests performed under ambient temperature and V_{DD} supply voltage conditions summarized in [Table 17](#).

Table 84. Embedded internal reference voltage

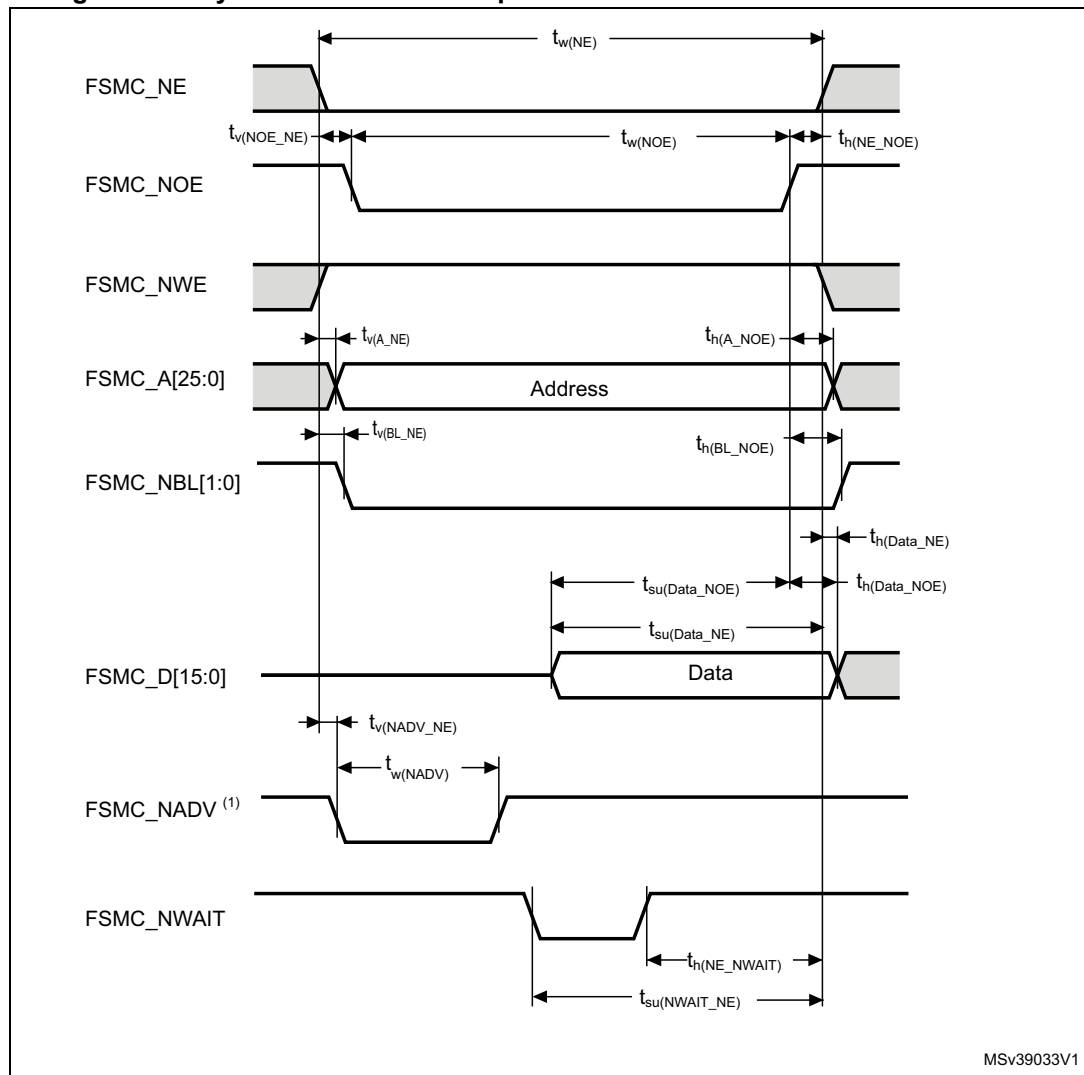
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{REFINT}	Internal reference voltage	$-40\text{ }^{\circ}\text{C} < T_A < +125\text{ }^{\circ}\text{C}$	1.18	1.21	1.24	V
$T_{S_vrefint}^{(1)}$	ADC sampling time when reading the internal reference voltage	-	10	-	-	μ s
$V_{RERINT_s}^{(2)}$	Internal reference voltage spread over the temperature range	$V_{DD} = 3V \pm 10\text{mV}$	-	3	5	mV
$T_{Coeff}^{(2)}$	Temperature coefficient	-	-	30	50	ppm/ $^{\circ}\text{C}$
$t_{START}^{(2)}$	Startup time	-	-	6	10	μ s

1. Shortest sampling time can be determined in the application by multiple iterations.
2. Guaranteed by design

Table 85. Internal reference voltage calibration values

Symbol	Parameter	Memory address
V_{REFIN_CAL}	Raw data acquired at temperature of 30 $^{\circ}\text{C}$ $V_{DDA} = 3.3\text{ V}$	0x1FFF 7A2A - 0x1FFF 7A2B

Figure 53. Asynchronous non-multiplexed SRAM/PSRAM/NOR read waveforms



1. Mode 2/B, C and D only. In Mode 1, FSMC_NADV is not used.

Table 106. LQFP64 - 64-pin, 10 x 10 mm low-profile quad flat package mechanical data

Symbol	millimeters			inches ⁽¹⁾		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	-	-	1.600	-	-	0.0630
A1	0.050	-	0.150	0.0020	-	0.0059
A2	1.350	1.400	1.450	0.0531	0.0551	0.0571
b	0.170	0.220	0.270	0.0067	0.0087	0.0106
c	0.090	-	0.200	0.0035	-	0.0079
D	-	12.000	-	-	0.4724	-
D1	-	10.000	-	-	0.3937	-
D3	-	7.500	-	-	0.2953	-
E	-	12.000	-	-	0.4724	-
E1	-	10.000	-	-	0.3937	-
E3	-	7.500	-	-	0.2953	-
e	-	0.500	-	-	0.0197	-
K	0°	3.5°	7°	0°	3.5°	7°
L	0.450	0.600	0.750	0.0177	0.0236	0.0295
L1	-	1.000	-	-	0.0394	-
ccc	-	-	0.080	-	-	0.0031

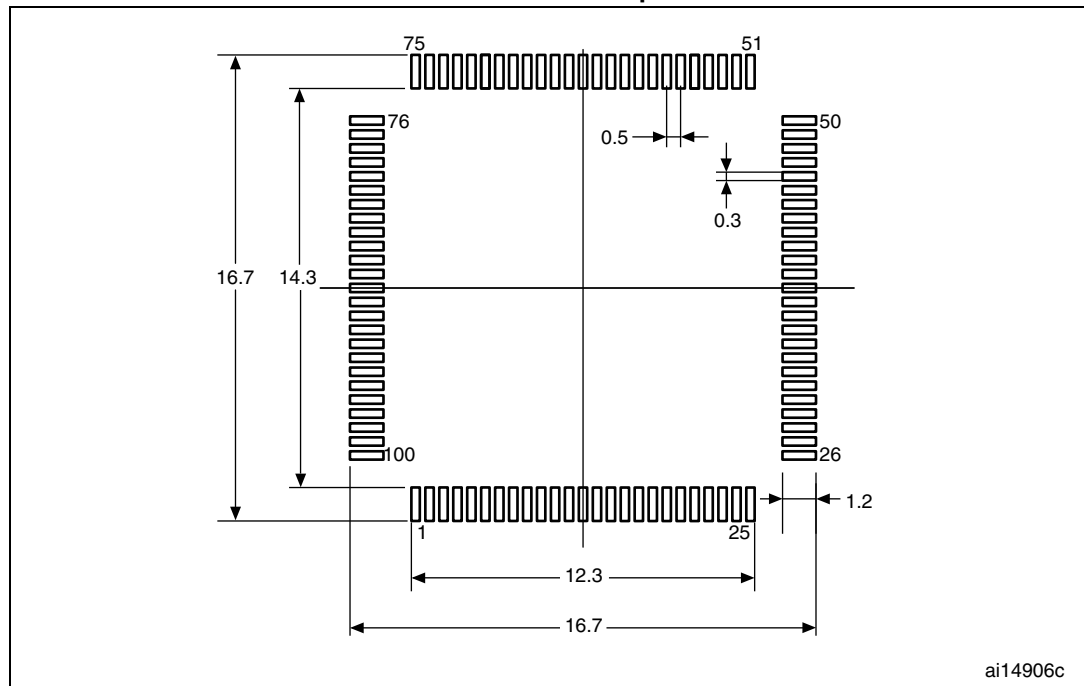
1. Values in inches are converted from mm and rounded to 4 decimal digits.

Table 107. LQPF100 - 100-pin, 14 x 14 mm low-profile quad flat package mechanical data (continued)

Symbol	millimeters			inches ⁽¹⁾		
	Min	Typ	Max	Min	Typ	Max
E1	13.800	14.000	14.200	0.5433	0.5512	0.5591
E3	-	12.000	-	-	0.4724	-
e	-	0.500	-	-	0.0197	-
L	0.450	0.600	0.750	0.0177	0.0236	0.0295
L1	-	1.000	-	-	0.0394	-
k	0.0°	3.5°	7.0°	0.0°	3.5°	7.0°
ccc	-	-	0.080	-	-	0.0031

1. Values in inches are converted from mm and rounded to 4 decimal digits.

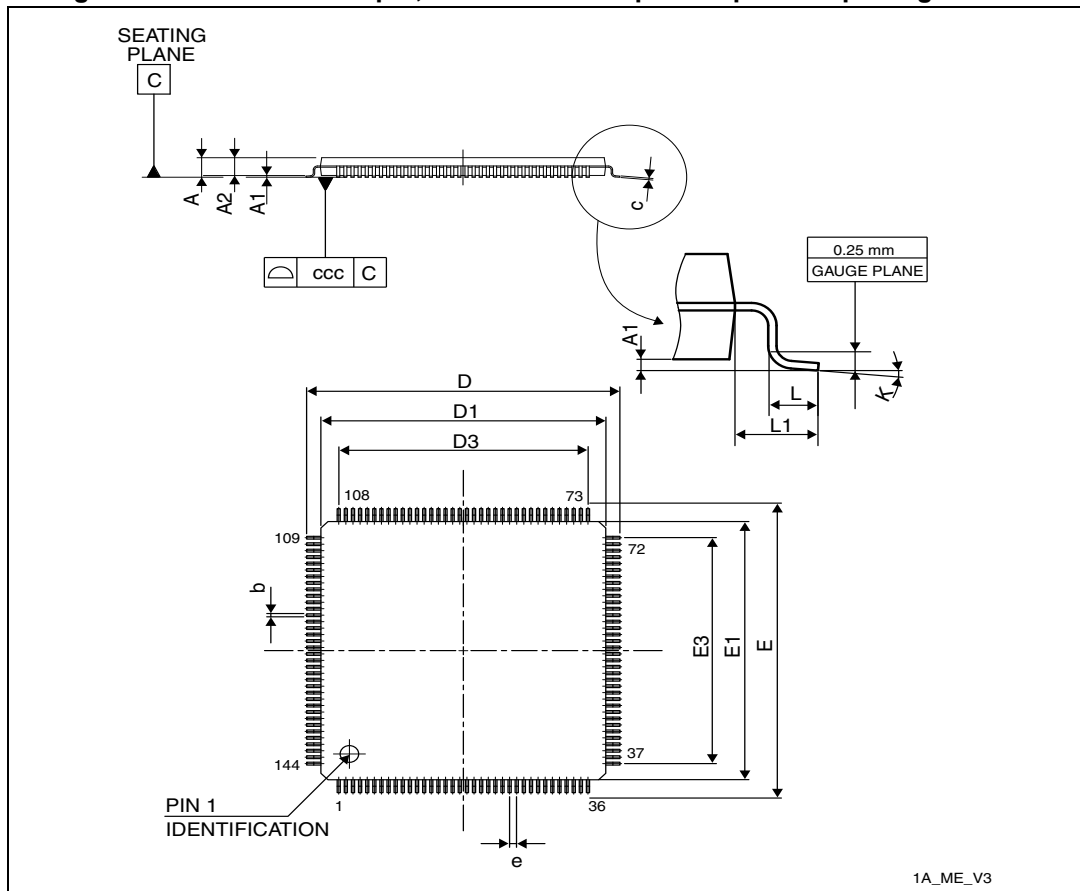
Figure 73. LQFP100 - 100-pin, 14 x 14 mm low-profile quad flat recommended footprint



1. Dimensions are in millimeters.

7.5 LQFP144 package information

Figure 75. LQFP144 - 144-pin, 20 x 20 mm low-profile quad flat package outline



1. Drawing is not to scale.